Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/775,139	KRAMER ET AL.	
Examiner	Art Unit	
Devin Hanan	3745	

	SEAR	CHED	
Class	Subclass	Date	Examiner
415	12		
	200		
416	241R		
	241B		
	248	6/10/2005	DH
updated	above	9/15/2005	DH

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
see into	ferace				
Scarch	report				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
consulted Ninh Nguyen on class 415 and 416	6/3/2005	DH	
consulted Chris Verdier on class 415 and 416	6/8/2005	DH	
Plus search	6/10/2005	DH	